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INFORMATION DISCLOSURE CITATION PTO-1449 Atty. Docket No. 050226 RADENARY

Serial No. 10/530,412

Applicant(s): SHIMIZU, Seiya, et al.

Filing Date: April 7, 2005

Group Art Unit: 1711

## **U.S. PATENT DOCUMENTS**

Examiner Initial	·	Document No.	Name	Date	Class	Subclass	Filing Date (If appropriate)
<u>Qe</u>	AA	5,288,784	Minayoshi	02/22/1994			
Ec	AB	5,007,964	Tsukisaka et al.	04/16/1991			
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		Document No.	Date	Country	Translation (Yes or No)
De	AD	2002-220547	08/09/2002	Japan	Yes
	AE	WO 99/51691	10/14/1999	PCT	- 14
	AF	05-117443	05/14/1993	Japan	Yes
	AG	10-72215	03/17/1998	Japan	Yes
	AH	2000-350920	12/19/2000	Japan	Yes
	AI	3260881	12/14/2001	Japan	Yes
	AJ	43-3487	02/08/1968	Japan	Yes, Abstract and copy of corresponding document: GB962812
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## **OTHER DOCUMENTS**

<u> </u>	AL	A copy of International Search Report for corresponding International Application No. PCT/JP03/13127 dated February 17, 2004.
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# JC05 Rec' T/PTO 07 APR 2005

INFORMATION DISCLOSURE STATEMENT PTO-1449 Atty. Docket No. 050226

Serial No. New Application 2

Applicant(s): Seiya SHIMIZU, et al.

Filing Date: April 7, 2005

Group Art Unit: Not Yet Assigned

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Pe	AA	5,288,784	S. Minayoshi	02/22/94		2151 100,000	
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	AG	5-117443	05/14/93	Japan	
	AH	10-72215	03/17/98	Japan	
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